

<b>Notice of References Cited</b>	Application/Control No. 10/606,258	Applicant(s)/Patent Under Reexamination CHIN ET AL.	
	Examiner Usmaan Saeed	Art Unit 2166	Page 1 of 1

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**NON-PATENT DOCUMENTS**

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	U	Sedra et al. "Microelectronic circuits", Oxford University Press, 1998, Pages 354- 358
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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